

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
CHOI, WOO-HYUK

Examiner

Dung Nguyen

Art Unit

2871

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,288,414	09-2001	Ahn, Byung Chul	257/72
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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